

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application)	<u>PATENT APPLICATION</u>
)	
Inventors: Ware, et al.)	
)	Art Unit: 2829
Application No.: 10/768,443)	
)	Examiner: Nguyen, Trung Q.
Filed: January 30, 2004)	
)	Customer No.: 38456
Title: METHOD AND APPARATUS FOR TEST)	
AND CHARACTERIZATION OF)	
SEMICONDUCTOR COMPONENTS)	

COMMENTS ON STATEMENT OF REASONS FOR ALLOWANCE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In the Notice of Allowance & Fee(s) Due dated May 5, 2009, the Examiner provided Reasons for Allowance (hereinafter referred to as the "REASONS"). Applicant believes that the REASONS, to the extent understood, may be misconstrued and, as such, are incomplete. Applicant submits that indeed, the claims of the instant application, individually or in combination with other claims (via dependency), describe the patentable subject matter of Applicant's invention(s). Accordingly, the REASONS in no way bind or affect the interpretation, infringement, validity and/or enforceability of any claim(s) or patent(s) resulting from, or relating to this application.

Should further questions remain, the Examiner is invited to contact the undersigned attorney by telephone.

Respectfully submitted,

Date: July 30, 2009 By: /Kirk J. DeNiro/
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